TA ADOMAN FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE ATTY, DOCKET NO.: 200.1163US SERIAL NO.: 10/562,494 (REV. 7-80) PATENT AND TRADEMARK OFFICE LIST OF PRIOR ART CITED BY APPLICANT APPLICANT(S): Benjamin OSHLACK et al. (Use several sheets if necessary) GROUP: 1617 FILING DATE: September 9, 2004 **U.S. PATENT DOCUMENTS** \*EXAMINER **DOCUMENT NUMBER** DATE NAME CLASS **SUBCLASS FILING DATE** INITIAL IF APPROPRIATE AΑ 6 0 9 0 12/21/99 0 O'Malley et al. ΑB 6 5 5 2 0 3 04/22/03 Burch et al. ΑC 1 5 8 7 12/05/06 Oshlack et al. 2 7 ΑD 7 1 6 02/06/07 Kaiko et al. 7 3 2 02/19/08 ΑE 3 8 2 Sackler 7 AF 6 5 0 0 6 07/20/04 Crain et al. AG 6 0 8 6 0 09/19/00 Whitmire ΑН 6 5 9 1 08/14/01 Foss et al. ΑI 20 02 00 58 6 7 3 05/16/02 Kaiko et al. 7 ΑJ 20 03 01 91 4 10/09/03 Sherman et al. 7 ΑK 20 03 00 73 1 4 04/17/03 Breder et al. ΑL 20 04 01 86 1 2 1 09/23/04 Oshlack et al. 7 AM 20 03 00 68 3 1 04/10/03 Oshlack et al. 03 ΑN 20 01 57 6 8 08/21/03 Breder et al. 2 ΑQ 20 03 00 6 3 69 11/18/03 Oshlack et al. ΑP 20 04 01 7 5 92 1 09/30/04 Chasin et al. AQ FOREIGN PATENT DOCUMENTS **DOCUMENT NUMBER** DATE COUNTRY CLASS **SUBCLASS** TRANSLATION YES NO AR OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.) AS **EXAMINER** DATE CONSIDERED /Renee Claytor/ 02/12/2009 \*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

OCT 06 2008

FORM PTO-1449 (REV. 7-80)									F COMMERCE MARK OFFICE	ATTY. DOCKET NO.: 200.1163US		SERIAL NO.: 10/562,494		
LIST OF PRIOR ART CITED BY APPLICANT										APPLICANT(S): Benjamin OSHLACK et al.				
(Use several sheets if necessary)										FILING DATE: Septen	nber 9, 2004	GROUP: 1617		
	_							U.	S. PATENT DO	CUMENTS				
*EXAMINER INITIAL		DOCUMENT NUMBER DATE								NAME	CLASS	SUBCLASS	FILING DATI	
	ВА	20	04	00	92	5	4	2	05/13/04	Oshlack et al.				
	BB	20	05	00	95	2	9	1	05/05/05	Oshlack et al.				
	вс	20	05	01	81	0	4	6	08/18/05	Oshlack et al.				
	BD	20	05	02	45	4	8	3	11/03/05	Brogmann et al.				
	BE	20	05	02	45	5	5	6	11/03/05	Brogmann et al.				
	BF	20	05	02	45	5	5	7	11/03/05	Schoenhard et al.				·
	BG	20	04	02	28	9	2	4	11/18/04	Oshlack et al.				
	ВН	20	06	00	39	9	7	0	02/23/06	Oshlack et al.				
	ВІ	20	06	01	82	8	0	1	08/17/06	Breder et al.				
	ВЈ	20	07	00	14	7	3	2	01/18/07	Sackler				
	ВК	20	07	01	22	3	4	8	05/31/07	Kaiko et al.				
	BL	20	07	00	14	7	3	2	01/18/07	Sackler				
	ВМ	20	08	00	20	0	2	8	01/24/08	Shevchuk et al.				
			E											
FOREIGN PATENT DOCUMENTS														<del></del>
		DOCUMENT NUMBER DATE								COUNTRY	CLASS	SUBCLASS	TRANSLATION	
													YES	NO
	BN	2	4	0	0	5	6	7	01/15/2008	CA				
	во	01	5	4	8	4	5	1	08/01/2001	wo				
	ВР	9	9	3	2	1	1	9	07/01/1999	wo				
	BQ	03	0	1	3	5	2	5	02/20/2003	wo				
					70	HER P	RIOR A	RT (Inc		tle, Date, Pertinent Page	s, Etc.)		<u> </u>	
	BR								, , , , , , , , , , , , , , , , , , , ,					
EXAMINER	/Rene	ee Cl	layto	r/				•		DATE CONSIDERED 02/12/2009				
*EXAMINER: Initia	I if referen	nce cons	sidered cation t	, whethe	er or no	1 citatio	n is in c	onform	ance with MPEP	609; Draw line through c	itation if not in c	onformance and no	t considered. In	clude